

Transaction Information

Tool ID	PROMOS_1158/082
Tool Status	Disconnected
Location	Singapore
Wafer Size	300 mm
Fab Section	Test
Tool Available Date	2023-08-08

General Product Information

Vendor Supplier	TEL
Model	P12
Vintage	2004
Serial No	PN00453
Asset Description	PROMOS_1158/082 FA Eqt_MAC0450_TEL Auto Probing Machine Model
Software Version	NA
CIM	NA
Process	Wafer Testing

Hardware Configuration (Fab)

System Type	Description	Quantity	Status
Main System	TEL P12 Prober	1	
Handler System	NA		
Factory Interface	Open Cassette	1	
Options System			

Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NA		

Missing/Faulty Parts / Accesories List

Description	Quantity
HDD Board	1
Prober LCD screen	1
VIP3A	1

Tool Pictures

General

Prober



Missing Parts

Prober LCD screen, VIP3A, HDD Board



Missing Parts

Prober LCD screen, VIP3A, HDD
Board



Missing Parts

Prober LCD screen, VIP3A, HDD
Board



Additional Configuration Files